

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/605,162	YU, JIAN-SHEN	
Examiner (Nancy) Thanh-Nhan P Nguyen		Art Unit 2871	Page 1 of 1	

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-20040246246	12-2004	Tobita, Youichi	345/205
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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